


<b>Search Notes</b> 	<b>Application/Control No.</b> 10567434	<b>Applicant(s)/Patent Under Reexamination</b> ABE ET AL.
	<b>Examiner</b> Hau V Phan	<b>Art Unit</b> 3618

SEARCHED			
Class	Subclass	Date	Examiner
180	65.2, 65.3, 65.4, 65.6, 65.8	11/19/08	HP
903	903, 905, 906, 910	11/19/08	HP
477	3, 5	11/19/08	HP

SEARCH NOTES			
Search Notes		Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
180	65.1-65.8	11/19/2008	HP

	/Hau V Phan/ Primary Examiner.Art Unit 3618
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